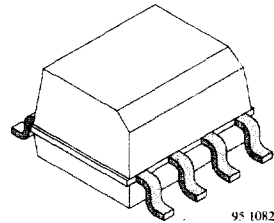


**Surface Mount Optocoupler with Phototransistor Output**

Order Nos. and Classification table is on sheet 2.

**Description**

The TCMT1020 series consists of a gallium arsenid infrared-emitting diode, optically coupled to a silicon NPN epitaxial planar transistor in an 8-lead SOIC package (small outline).



**Applications**

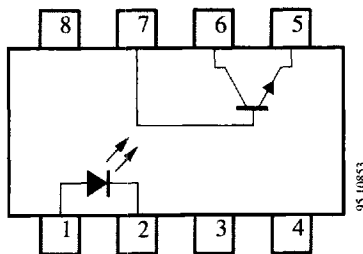
- Computer peripheral interface
- Microprocessor system interface
- Hybride substrates that require high density mounting
- DC/DC converter



**Features**

- Current Transfer Ratio (CTR) selected into 4 groups, specified at  $I_F = 10 \text{ mA}$
- Test isolation voltage between input and output  $V_{IO} \text{ (RMS)}$ : 2.5 kV
- 8-lead package, similar to SOIC-8
- Minimum  $V_{(BR)CEO}$  of 90 V guaranteed
- Suitable for cleaning process without chemical solvent
- Soldering methods according to CECC 00802 table 1, class B or C
- Low temperature coefficient of CTR
- Base connected

**Pin Connection**



## Order Schematic

Part Numbers	CTR-Ranking
TMCT1020/ TCMT1020-GS12	>40%
TMCT1021/ TCMT1021-GS12	40 to 80%
TMCT1022/ TCMT1022-GS12	65 to 125%
TMCT1023/ TCMT1023-GS12	100 to 200%
TMCT1024/ TCMT1024-GS12	160 to 320%

Suffix: GS12 = Taped and reeled version

## Absolute Maximum Ratings

### Input (Emitter)

Parameters	Test Conditions	Symbol	Value	Unit
Reverse voltage		$V_R$	5	V
Forward current		$I_F$	60	mA
Forward surge current	$t_p \leq 10 \mu s$	$I_{FSM}$	3	A
Power dissipation	$T_{amb} \leq 25^\circ C$	$P_{tot}$	100	mW
Junction temperature		$T_j$	125	$^\circ C$

### Output (Detector)

Parameters	Test Conditions	Symbol	Value	Unit
Collector base voltage		$V_{CBO}$	90	V
Collector emitter voltage		$V_{CEO}$	90	V
Emitter collector voltage		$V_{ECO}$	7	V
Collector current		$I_C$	50	mA
Collector peak current	$t_p/T = 0.5, t_p \leq 10 \text{ ms}$	$I_{CM}$	100	mA
Power dissipation	$T_{amb} \leq 25^\circ C$	$P_{tot}$	150	mW
Junction temperature		$T_j$	125	$^\circ C$

### Coupler

Parameters	Test Conditions	Symbol	Value	Unit
AC isolation test voltage (RMS)		$V_{IO}^{1)}$	2.5	kV
Total power dissipation	$T_{amb} \leq 25^\circ C$	$P_{tot}$	250	mW
Ambient temperature range		$T_{amb}$	-55 to +100	$^\circ C$
Storage temperature range		$T_{stg}$	-55 to +125	$^\circ C$
Soldering classification	Single wave, $t \leq 10 \text{ s}$	$T_{sd}$	260	$^\circ C$

<sup>1)</sup> Related to standard climate 23/50 DIN 50014

**Electrical Characteristics**

T<sub>amb</sub> = 25°C

**Input (Emitter)**

Parameters	Test Conditions	Type	Symbol	Min.	Typ.	Max.	Unit
Forward voltage	I <sub>F</sub> = 50 mA		V <sub>F</sub>		1.25	1.6	V
Breakdown voltage	I <sub>R</sub> = 100 μA		V <sub>(BR)</sub>	5			V
Junction capacitance	V <sub>R</sub> = 0, f = 1 MHz		C <sub>J</sub>		50		pF

**Output (Detector)**

Parameters	Test Conditions	Type	Symbol	Min.	Typ.	Max.	Unit
Collector base breakdown voltage	I <sub>C</sub> = 100 μA		V <sub>(BR)CB0</sub>	90			V
Collector emitter breakdown voltage	I <sub>C</sub> = 1 mA		V <sub>(BR)CEO</sub>	90			V
Emitter collector breakdown voltage	I <sub>E</sub> = 100 μA		V <sub>(BR)ECO</sub>	7			V
Collector emitter cut-off current	V <sub>CE</sub> = 10 V, I <sub>F</sub> = 0		I <sub>CEO</sub>			50	nA

**Coupler**

Parameters	Test Conditions	Type	Symbol	Min.	Typ.	Max.	Unit
AC isolation test voltage (RMS)	f = 50 Hz, t = 1 s		V <sub>IO</sub>	2.5			kV
Collector emitter saturation voltage	I <sub>F</sub> = 10 mA, I <sub>C</sub> = 1 mA		V <sub>CEsat</sub>			0.3	V
Cut-off frequency	V <sub>CE</sub> = 5 V, I <sub>F</sub> = 10 mA, R <sub>L</sub> = 100 Ω		f <sub>C</sub>		110		kHz
Coupling capacitance	f = 1 MHz		C <sub>k</sub>		0.3		pF

**Current Transfer Ratio (CTR)**

Parameters	Test Conditions	Type	Symbol	Min.	Typ.	Max.	Unit
I <sub>C</sub> /I <sub>F</sub>	V <sub>CE</sub> = 5 V, I <sub>F</sub> = 10 mA	TCMT1020	CTR	0.2			
		TCMT1021		0.4		0.8	
		TCMT1022		0.65		1.25	
		TCMT1023		1		2	
		TCMT1024		1.6		3.2	

## Switching Characteristics (Typical Values)

$V_S = 5\text{ V}$

Type	$R_L = 100\ \Omega$ (see figure 1)						
	$t_d[\mu\text{s}]$	$t_r[\mu\text{s}]$	$t_{on}[\mu\text{s}]$	$t_f[\mu\text{s}]$	$t_{off}[\mu\text{s}]$	$t_{on}[\mu\text{s}]$	$I_C[\text{mA}]$
TCMT1020/ TCMT1020-GS12	>0.70	>1.35	>1.70	>0.15	>1.35	>1.50	5
TCMT1021/ TCMT1021-GS12	0.70	1.35	1.70	0.15	1.35	1.50	5
TCMT1022/ TCMT1022-GS12	1.20	190	2.80	0.20	1.90	2.10	5
TCMT1023/ TCMT1023-GS12	1.60	2.90	4.10	0.30	2.90	3.20	5
TCMT1024/ TCMT1024-GS12	2.20	4.80	5.90	0.40	4.80	5.20	5

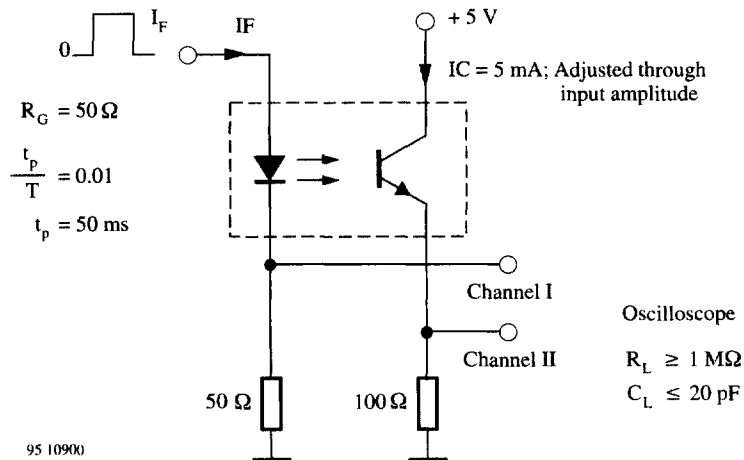


Figure 1. Test circuit, non-saturated operation

**Typical Characteristics** ( $T_{amb} = 25^{\circ}\text{C}$ , unless otherwise specified)

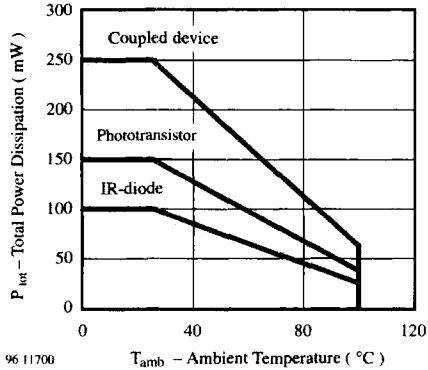


Figure 1. Total Power Dissipation vs. Ambient Temperature

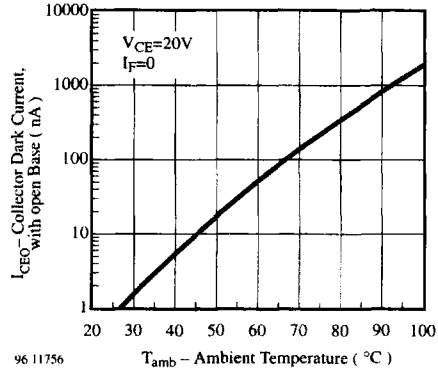


Figure 4. Collector Dark Current vs. Ambient Temperature

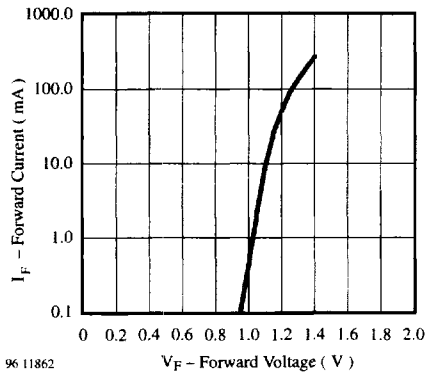


Figure 2. Forward Current vs. Forward Voltage

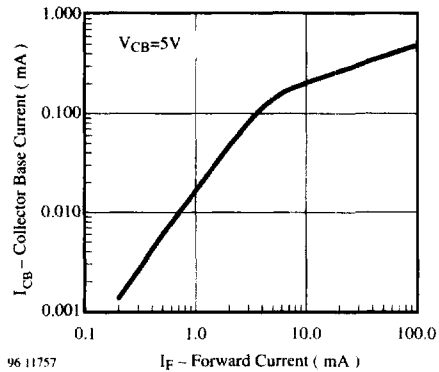


Figure 5. Collector Base Current vs. Forward Current

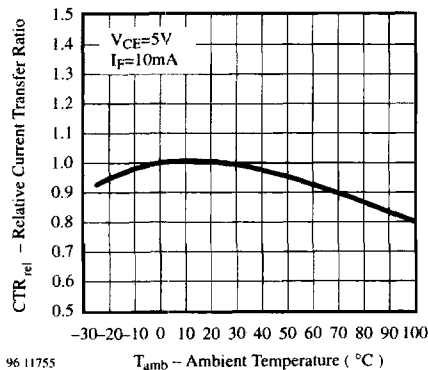


Figure 3. Rel. Current Transfer Ratio vs. Ambient Temp.

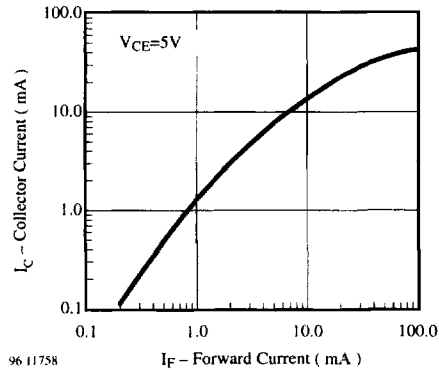


Figure 6. Collector Current vs. Forward Current

## Typical Characteristics ( $T_{amb} = 25^{\circ}\text{C}$ , unless otherwise specified)

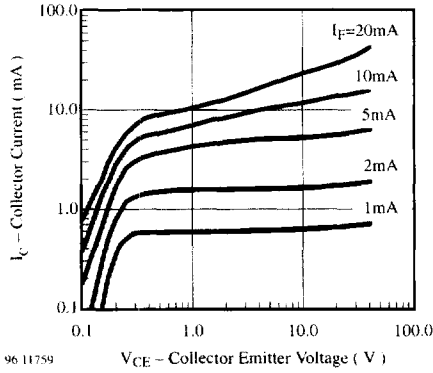


Figure 7. Collector Current vs. Collector Emitter Voltage

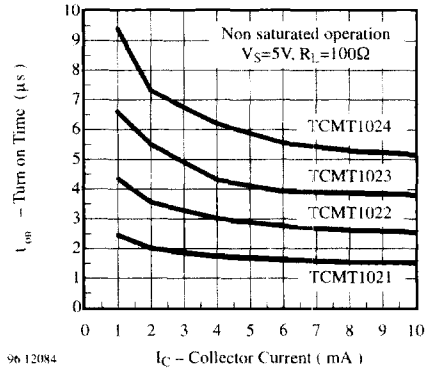


Figure 10. Turn on Time vs. Collector Current

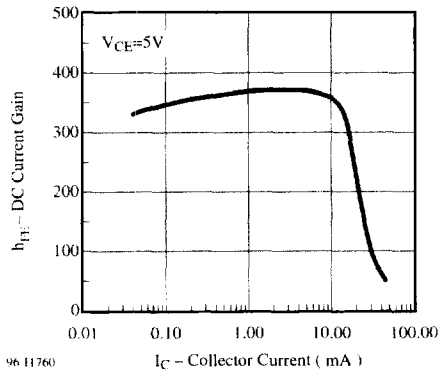


Figure 8. DC Current Gain vs. Collector Current

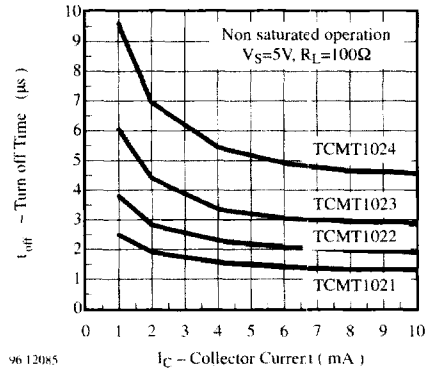


Figure 11. Turn off Time vs. Collector Current

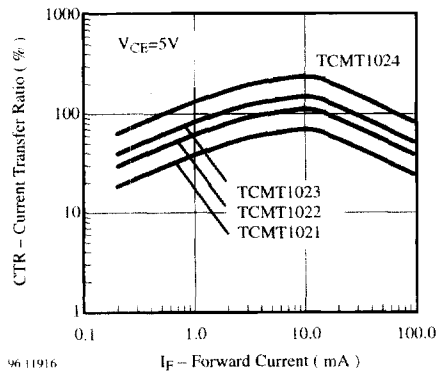
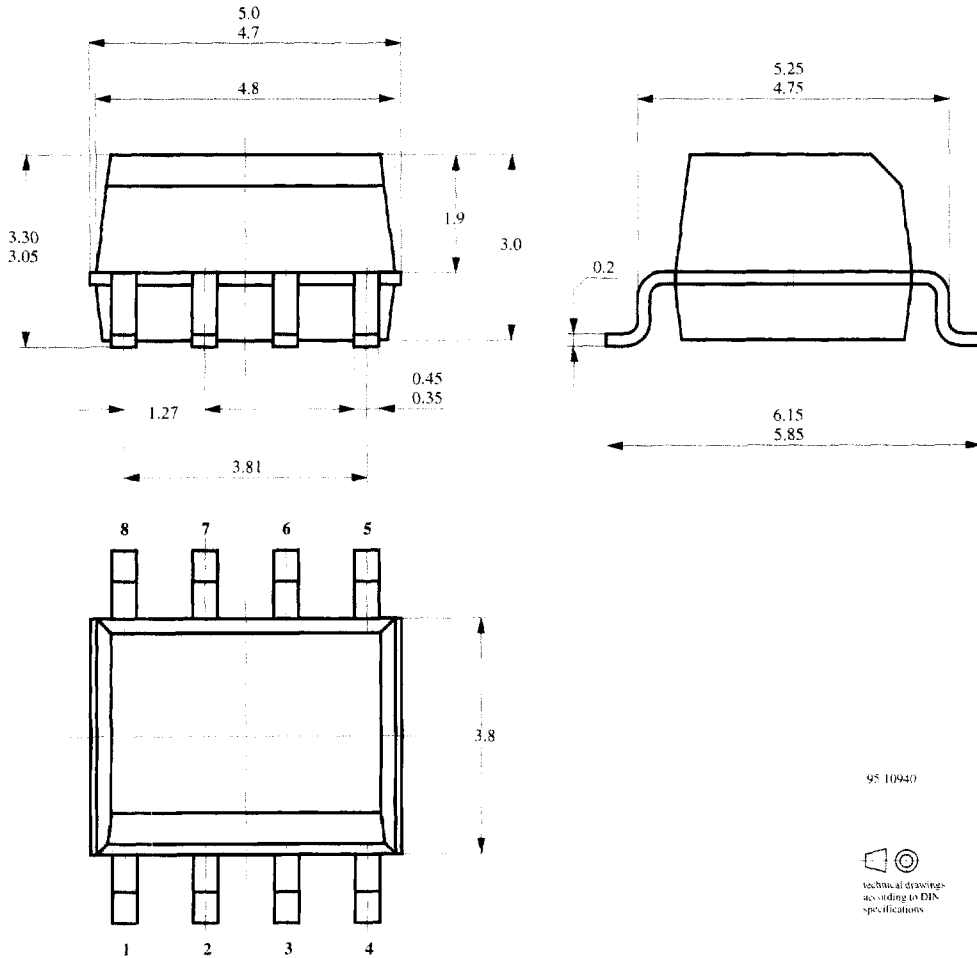


Figure 9. Current Transfer Ratio vs. Forward Current

**Dimensions in mm**



95 10940

  
Technical drawings  
according to DIN  
specifications